## Notice of References Cited Application/Control No. 10/601,460 Examiner Brij B Shrivastav Applicant(s)/Patent Under Reexamination AN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,111,408 A	08-2000	Blades et al:	324/303
	В	US-6,147,490 A	11-2000	Watanabe, Hidehiro	324/307
X	С	US-5,317,261 A	05-1994	Den Hollander et al.	324/309
Ϋ́	D	US-6,617,169 B2	09-2003	Ke et al.	436/173
Х	E	US-6,472,870 B1	10-2002	Bendall et al.	324/307
X	F	US-6,111,409 A	08-2000	Edwards et al.	324/303
大	G	US-6,104,191 A	08-2000	Hurd, Ralph E.	324/310
Х	Н	US-5,043,664	08-1991	Kunz, Dietmar W.	324/307
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	J	US-	· · · · · · · · · · · · · · · · · · ·		
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Т					

## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	;
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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